

Course Manual LMK

Light microscopy

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– General information

Long name Light microscopy

Approving CModule LMK BaET, LMK BaET

Responsible Prof. Dr. Stefan Altmeyer
Professor Fakultät IME

Valid from winter semester
2022/23

Level Bachelor

Semester in the year winter semester

Duration Semester

Hours in self-study 78

ECTS 5

Professors Prof. Dr. Stefan Altmeyer
Professor Fakultät IME

Requirements mathematics;
vector calculus
complex numbers

physics / optics:
geometrical optics
wave optics

Language German

Separate final exam Yes

Literature

keine

Final exam

Details

As long as the number of participants is not too high, oral examination is preferred of written exams.

Lowest competence level checked is knowledge. This could be e.g. structural components that are present in every microscope, the raypath of a transmission and a reflexion microscope with Köhler illumination, the location of the angular apertur and the phase ring in a Zernike phase microscope or the reason for the direction selectivity in a differential interference contrast microscope.

The next competence level is related to skills. Examination could be done by the calculation

of required parameters of key components in a microscope, either on the basis of given application specifications or by the specification of some components, that are already in use. Furthermore it can be checked, if the setup of Köhler illumination can be explained, ideally with explanatory statements.

The highest competence level addressed is methodical expertise. It can be checked by the discussion of a real world task: E.g.: Determine the radius of curvature of a lens. Here the choice of the right type of microscope is already important. Furthermore the process of data acquisition and the data manipulation good methodical expertise. Another task could be to measure quantitatively the relative phase shift of two structures in an object.

Minimum standard	Correct answer of at least 50 % of the questions
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Exam Type	EN mündliche Prüfung, strukturierte Befragung
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– Lecture / Exercises

Learning goals

Goal type	Description
Knowledge	<p>depth of field paraxial, on the object side near and far point hyperfocal distance wace optical, on the image side</p> <p>amplitude- and phase objects law of Lamberr-Beer optical density phase, refraction index and optical distance Abbe's theory of image formation relative phase of diffraction orders of amplitude objects of phase objects</p> <p>phase microscope with phase disc location and size of zero'th diffraction order spatial coherence diffraction artefacts Zernike location and size of zero'th diffraction order spatial coherence the principle of Babinet diffraction artefacts visibility and contrast attenuation in the phase ring</p> <p>coherence visibility of interference temporal coherence lenght of wavetrains spectral composition of wavetrains time shifted arrival of amplitude split wavetrains fast change of interference patterns coherence time spatial coherence spatially split wavetrains phase shift in spatially split wavetrains in dependence of the location of the origin spatial overlay of interference patterns spatial coherence length</p> <p>interferometer Michelson compensation plate</p>

Special requirements

none

Accompanying material	lecture notes as downloadable file
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Separate exam	No
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second interference pattern
Mach-Zehnder
phase shifts on reflexions
complementary interference
patterns
contrast of unequal splitted
wavefronts
ambiguity of interference
patterns
white light interferometer
interference colors and contrast
function

interference microscope
Linnik
sorted pairs of objectives
Michelson
long work distance objectives
Mirau
Schwarzschild objectives
differential interference contrast
birefringence
modification of Huygens' principle
indicatrix
Wollaston-, Nomarski- and Smith
prisms
splitting below resolution
interference colors
base optical path difference and
lambda plate
coherence requirements in the DIC
temporal
spatial
transmission-interference
microscopes
Leitz' Mach-Zehnder interference
microscope
interphaco microscope

Skills

calculate depth of field

convert optical density, dynamic in images and absorption coefficients into on another

determine phase discontinuities at interfaces quatitatively

calaculate sizes of phase rings and angular apertures of Zernike phase microscopes

calculate the strength of diffraction orders and derive image contrast from them

estimate temporal coherence from bandwith of frequencies and wavelengths and vice versa

estimate spatial coherenece from lightsource size and distance and vice versa

draw ray paths of the different interference micorscopes and explain them

calculate the requirements regarding coherence in the different interference microscopes

calculate geometries from ackquired interferograms

predict colors in white light interferometry

explain and compare physically and technically the underlying principles of different microscopes

Expenditure classroom teaching

Type	Attendance (h/Wk.)
Lecture	2
Tutorial (voluntary)	0

– Practical training

Learning goals

Goal type	Description
Skills	set up Köhler illumination balancing lengths and angles in interferometers prepare objects for microscopy set up, adjust and use microscopes, especially bright field dark field reflexion transmission Zernike phase contrast Linnik interference contrast differential interference contrast choose a suitable microscopy principle for a given object and task tell artefacts from object details judge image quality write scientific report describe the task describe the idea of the solution explain the experimental setup explain the data processing make error analysis present the results and make a critical discussion

Expenditure classroom teaching

Type	Attendance (h/Wk.)
Practical training	2
Tutorial (voluntary)	0

Special requirements

none

Accompanying material

Instrcutions for the experiments as downloadable files.

Operating manuals for complex equipment as downloadable files.

Separate exam

Yes

Separate exam

Exam Type

EN Projektaufgabe im Team bearbeiten (z.B. im Praktikum)

Details

1) Written examination questions related to the experiment have to be prepared at home and shown at the beginning of the laboratory.

2) The underlying ideas of the experiment have to be explained at the beginning of the laboratory.

3) Make the experiment alone (preferred) or in a team of two.

- Build up and adjust your own setup
- Acquire / measure data with this setup

4) Write a documentation on the experiment. It will be checked with regard to

- completeness
- scientific and precise language
- correctness
- understanding of the interrelations and interpretation of the results

Minimum standard

All written tasks must have been dealt with.

The basic ideas of the experiment must have been understood.

All experiments must have been performed.

The reports must be free of systematical errors.